

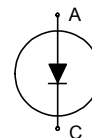
1200V thinQ!TM SiC Schottky Diode

Features:

- Revolutionary Semiconductor Material - Silicon Carbide
- Switching Behaviour Benchmark
- No Reverse Recovery / No Forward Recovery
- Temperature Independent Switching Behaviour
- Qualified According to JEDEC¹⁾ Based on Target Applications

Applications:

- Motor Drives / Solar Inverters
- High Voltage CCM PFC
- Switch Mode Power Supplies
- High Voltage Multipliers



Chip Type	V _{BR}	I _F	Die Size	Package
IDC08S120E	1200V	7.5A	2.012 x 2.012 mm ²	sawn on foil

Mechanical Parameters

Raster size	2.012 x 2.012	mm ²
Anode pad size	1.476 x 1.476	
Area total	4.05	
Thickness	362	µm
Wafer size	100	mm
Max. possible chips per wafer	1652	
Passivation frontside	Photoimide	
Pad metal	3200 nm Al	
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding	
Die bond	Electrically conductive glue or solder	
Wire bond	Al, ≤ 350µm	
Reject ink dot size	Ø ≥ 0.3 mm	
Recommended storage environment	Store in original container, in dry nitrogen, in dark environment, < 6 month at an ambient temperature of 23°C	

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}	$T_{vj} = 25^{\circ}\text{C}$	1200	V
DC blocking voltage	V_{DC}		1200	
Continuous forward current, limited by T_{vjmax}	I_F	$T_{vj} < 150^{\circ}\text{C}$	7.5	A
Surge non repetitive forward current, sine halfwave	$I_{F,SM}$	$T_C = 25^{\circ}\text{C}, t_P = 10\text{ ms}$	39	
		$T_C = 150^{\circ}\text{C}, t_P = 10\text{ ms}$	33	
Repetitive peak forward current, limited by thermal resistance R_{th}	$I_{F,RM}$	$T_C = 100^{\circ}\text{C}, T_{vj} = 150^{\circ}\text{C}, D = 0.1$	32	
Non-repetitive peak forward current	$I_{F,max}$	$T_C = 25^{\circ}\text{C}, t_P = 10\mu\text{s}$	160	
i^2t value	$\int i^2 dt$	$T_C = 25^{\circ}\text{C}, t_P = 10\text{ ms}$	7	A ² s
		$T_C = 150^{\circ}\text{C}, t_P = 10\text{ ms}$	5	
Operating junction and storage temperature range	T_{vj}, T_{stg}		-55...+175	°C

Static Characteristics (tested on wafer)

Parameter	Symbol	Conditions	Value			Unit
			min.	Typ.	max.	
Reverse current	I_R	$V_R = 1200\text{V}, T_{vj} = 25^{\circ}\text{C}$		8	180	μA
Diode forward voltage	V_F	$I_F = 7.5\text{A}, T_{vj} = 25^{\circ}\text{C}$		1.6	1.8	V

Static Characteristics (not subject to production test - verified by design / characterization)

Parameter	Symbol	Conditions	Value			Unit
			min.	Typ.	max.	
Reverse current	I_R	$V_R = 1200\text{V}, T_{vj} = 150^{\circ}\text{C}$		30	1000	μA
Diode forward voltage	V_F	$I_F = 7.5\text{A}, T_{vj} = 150^{\circ}\text{C}$		2.5	3	V

Dynamic Characteristics (not subject to production test - verified by design / characterization)

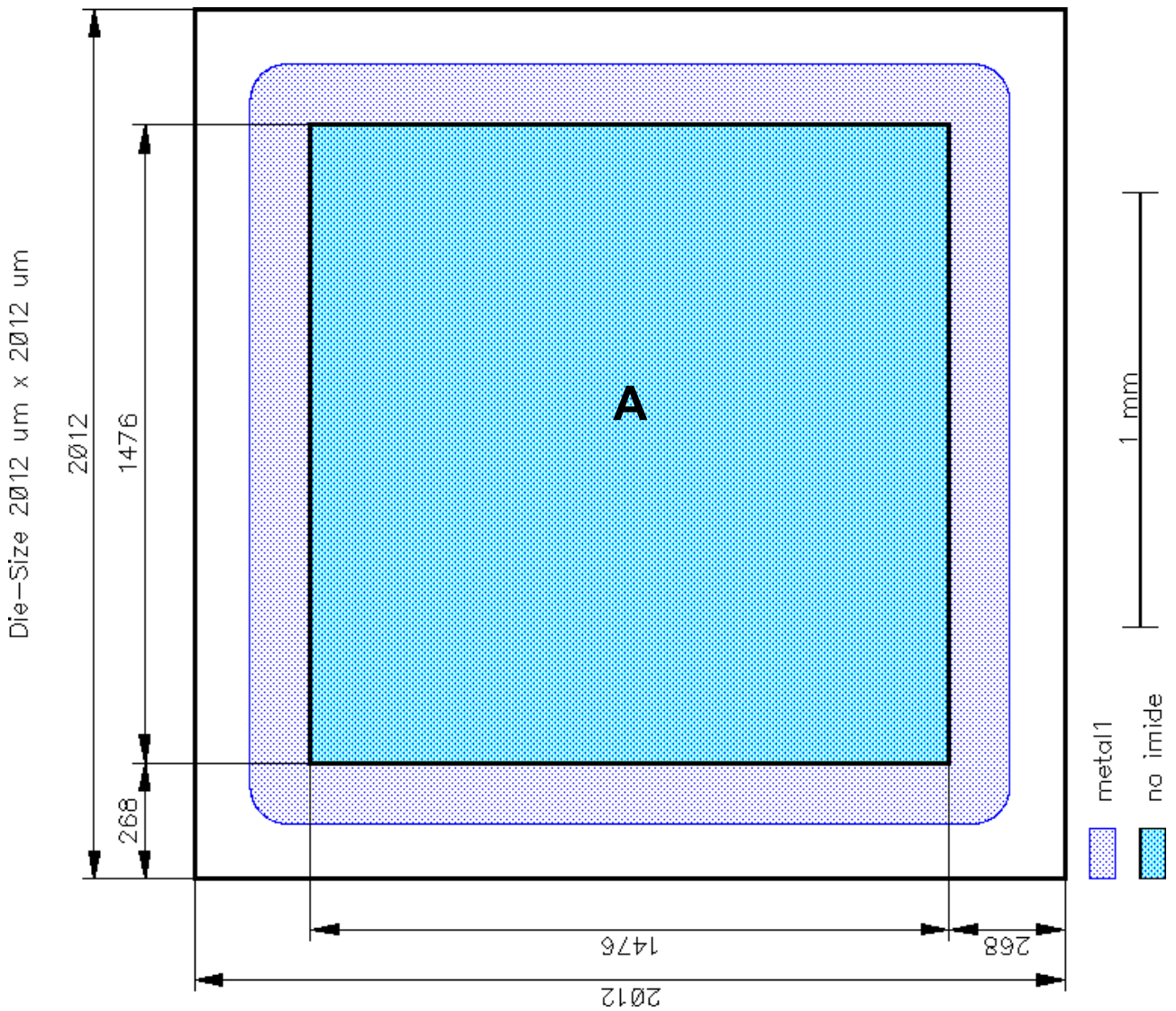
Parameter	Symbol	Conditions	Value			Unit	
			min.	Typ.	max.		
Total capacitive charge ³⁾	Q_C	$I_F \leq I_{F,max}$ $di/dt = 200 A/\mu s$ $V_R = 1200 V$	$T_{vj} = 150^\circ C$		27		nC
Switching time ²⁾	t_c		$T_{vj} = 150^\circ C$			<10	
Total capacitance	C	f=1MHz	$V_R = 1V$		380		pF
			$V_R = 300V$		30		
			$V_R = 600V$		27		

¹⁾ J-STD20 and JESD22

²⁾ t_c is the time constant for the capacitive displacement current waveform (independent from $T_{vj} = 150^\circ C$, I_{LOAD} and di/dt), different from t_{rr} , which is dependent on $T_{vj} = 150^\circ C$, I_{LOAD} , di/dt . No reverse recovery time constant t_{rr} due to absence of minority carrier inject.

³⁾ Only capacitive charge occurring, guaranteed by design (independent from T_{vj} , I_{LOAD} and di/dt).

Chip drawing



A: Anode pad



IDC08S120E

Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Published by
Infineon Technologies AG
81726 Munich, Germany
© 2009 Infineon Technologies AG
All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office. Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.